

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination SHUM ET AL.	
			Examiner Michael B. Holmes	Art Unit 2121	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	Subpicometer accuracy laser wavelength sensor using multiplexed Bragg gratings Feng Zhao; Sayano, K.; Miller, H.E.; Karlovac, N.; Photonics Technology Letters, IEEE ,Volume: 9 , Issue: 11 , Nov. 1997 Pages:1493 - 1495
*	V	Wavelength-stabilized Laser Source For Dense Wavelength-division Multiplexing Hendow, S.T.; Miller, H.E.; Sayano, K.; Karlovac, N.; Lasers and Electro-Optics, CLEO '97., Summaries of Papers Presented at the Conference on ,Vol.: 11 , Pages:27 - 28
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.